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Bib Data Sheet

CONFIRMATION NO. 9316

SERIAL NUMBER 10/786,468	FILING DATE 02/26/2004  RULE	CLASS 029	GROUP ART UNIT 3729	ATTORNEY DOCKET NO. 044499-0206
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## APPLICANTS

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\*\* CONTINUING DATA \*\*\*\*\*

\*\* FOREIGN APPLICATIONS \*\*\*\*\*

JAPAN 2003-050357 02/27/2003

IF REQUIRED, FOREIGN FILING LICENSE GRANTED

\*\* 05/18/2004

Foreign Priority claimed 35 USC 119 (a-d) conditions met	<input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance	STATE OR COUNTRY JAPAN	SHEETS DRAWING 7	TOTAL CLAIMS 8	INDEPENDENT CLAIMS 6
Verified and Acknowledged	<i>C. J. Lardner</i> Examiner's Signature Initials				

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## TITLE

Substrate inspecting method and substrate inspecting apparatus using the method

FILING FEE  RECEIVED 1158	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:	<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees ( Filing ) <input type="checkbox"/> 1.17 Fees ( Processing Ext. of time ) <input type="checkbox"/> 1.18 Fees ( Issue )
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